

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)  
(Use several sheets if necessary)

Date Submitted to PTO: June 23, 2004

ATTY DOCKET NO.  
2003\_1558ASERIAL NO.  
10/693,906APPLICANT  
Yosuke MIZUYAMA et al.FILING DATE  
October 28, 2003GROUP  
2681

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
S.T.	AA	2002/0109436	8/2002	Peng et al.			
S.T.	AB	2002/0050882	8/2002	Hyman et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
S.T.	AJ	2 753 565	3/1998	FR			
S.T.	AK	1 584 914	2/1981	GB			
	AL						
	AM						
	AN						

## OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

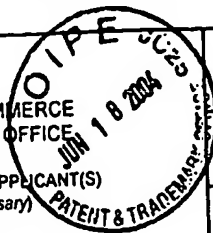
	AO	
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	AQ	

EXAMINER

SONNY TRINH  
PRIMARY EXAMINER S.T.

DATE CONSIDERED

2-10-06

Sheet 1 of 1		FORM PTO 1449 (modified)				ATTY DOCKET NO. 2003_1558A		SERIAL NO. 10/693,906	
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				APPLICANT Yosuke MIZUYAMA et al.					
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)				FILING DATE October 28, 2003				GROUP 2681	
Date Submitted to PTO: June 18, 2004									
U.S. PATENT DOCUMENTS									
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE		
	AA								
	AB								
	AC								
	AD								
	AE								
	AF								
	AG								
	AH								
	AI								
FOREIGN PATENT DOCUMENTS									
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO		
S.T.	AJ	2000-348594	12/2000	JP					
I	AK	11-340702	12/1999	JP					
S.T.	AL	2000-348595	12/2000	JP					
	AM								
	AN								
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)									
S.T.	AO	Chiaki TANUMA, et al., entitled "A HIGHLY SENSITIVE DISPLACING DEVICE USING PIEZOELECTRIC BIMORPH WITH DOUBLE-SUPPORT STRUCTURE", Proceedings of the 4th Meetings on Ferroelectric Materials and Their Applications, Kyoto 1983, Japanese Journal of Applied Physics, vol. 22 (1983) Supplement 22 - 2, pp. 154-156.							
	AP								
EXAMINER				SONNY TRINH PRIMARY EXAMINER			DATE CONSIDERED		
							2-10-06		

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of form with next communication to applicant.